

System-Level Simulation of a SPAD-Based Time-of-Flight Sensor in SystemVerilog

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Direct Time-of-Flight Method

• Detect direct time difference (TOF)



- Depth = $c/2 \times TOF$ ($c \approx 3 \times 10^8 \text{ [m/s]}$)
- The sensor's receiver utilizes a singlephoton avalanche diode (SPAD)





A Direct TOF Sensor

• 4 Primary Components



- (1) SPAD array, analog front-end (AFE) and signal combiner
- (2) Time-to-digital converter (TDC)
- (3) Histogramming and digital signal processing
- (4) Timing controller
- To predict the accuracy of the TOF sensor
 - we need a SPAD model that simulates the physical and statistical characteristics
 - A simulation platform is essential





XMODEL: Accurate Simulation in SystemVerilog

- XMODEL: plug-in extension to SystemVerilog developed by Scientific Analog
- *xbit* type can express precise timing information without being limited by the timestep of SystemVerilog simulation







SPAD & AFE Operation



- SPAD functions in Geiger mode
- Upon the incidence of a photon on the SPAD, a digital pulse is generated
- The width of the digital pulse is referred to as the SPAD dead-time (Tdead)





SPAD Characteristics

- Dark count rate (DCR), Dead-time (Tdead)
- Photon detection probability (PDP)







SPAD Modeling

- Calculates the generation time of noise pulse and photon-induced pulse through a Poisson process
- Generates output pulses with a user-defined pulse width of Tdead



- Proposed SPAD modeling performs:
 - Noise pulse generation
 - Photon-induced pulse generation
 - Dead time control





Noise Pulse Generator

- Thoise Generator generates the randomized timing of noise pulse initiation, *Thoise*
 - The mean frequency of noise pulse generation is DCR
- Single Pulse Generator creates *noise_pulse* with a width of *Tdead*









Tnoise Generator

- *Thoise* is ascertained from the Poisson process with a rate of λ
- The probability that the first dark count generation time, X_1 , exceeds time t
 - $P(X_1 > t) = P(no \ dark \ count \ generation \ between \ 0 \ and \ t) = e^{-\lambda t}$
- The probability that the first dark count generation occurs within the time t
 - $P(X_1 \le t) = 1 e^{-\lambda t}$
- The interarrival time $t = \frac{\ln(1 P(X_1 \le t))}{-\lambda}$
 - $t \rightarrow$ Thoise
 - $P(X_1 \le t) \rightarrow rand_uniform(0,1)$ function
 - $\lambda \rightarrow DCR$





Tnoise Generator (2)

- Thoise = $\frac{\ln(1-rand_uniform(0,1))}{-DCR}$
- Tnoise is updated every time gen has a falling edge
 - Considering *Thoise* ≥ *Tdead*



RSTB





Photon-induced Pulse Generator

- Tph Generator calculates the photon-induced pulse generation time, Tph
 - Inputs: the light pulse shape (*pulse_shape*), *TOF*, light intensity (*INT*), and *PDP*







Tph Generator

• It takes the light pulse shape (*pulse_shape*), photon arrival time (*TOF*), light intensity (*INT*), and photon detection probability (*PDP*) as inputs







Tph Generator (2)

- 1. *pulse_shape_disc* is obtained by discretizing the input *pulse_shape*
- 2. pulse_shape_int is achieved by normalizing pulse_shape_disc and multiplying it by INT
 - *Tres*: resolution time of *pulse_shape_int*

11 651 1 650		
module Tph_gen		//For normalizing pulse_shape_disc
		for(j=0; j<(pulse_len/interval)+1; j++) begin
always @(posedge RSTB) begin		<pre>if(pulse_shape_disc[j]<0) pulse_shape_disc[j] = 0;</pre>
signal_sequence = 0;	//Photon detection time within input light pulse	pulse_sum = pulse_sum + pulse_shape_disc[j];
Tph = 0;	<pre>//Photon detection time (= TOF + signal_sequence)</pre>	end
pulse_sum = 0;	//Sum of discretized pulse_shape data (pulse_shape_disc)	<pre>for(k=0; k<(pulse_len/interval)+1; k++) begin</pre>
		pulse_shape_int[k] = pulse_shape_disc[k] / pulse_sum * INT;
//For discretizing pulse_shape		end
//(Resolution time of pulse_shape_disc = (interval * 0.02) ns)		Tres = 0.02 * interval; //Tres: Resolution time of pulse_shape_int
<pre>for(i=0; i<(pulse_len/interval); i++) begin</pre>		
pulse_shape_disc[i+1] = pulse_shape[i*interval+int'(interval/2)+1];		
end		





Tph Generator (3)

- 3. Use the cumulative distribution function (cdf) of the Poisson process to calculate at which point within *pulse_shape_int* (λ) the SPAD reacts.
 cdf = ∑ⁿ_{k=0} e^{-λ}λ^k/k|
 - The value of k increments by one until cdf > thres_cdf (=rand_uniform(0,1))
 - The derived k: the number of photons successfully reaching the SPAD

```
//For modeling photon arrival and SPAD avalanche
for(i=0; i<(pulse_len/interval)+1; i++) begin
k = 0; cdf = 0; kfactorial = 1; thres_cdf = rand_uniform(0,1);
while (1) begin
cdf = cdf + $exp(-pulse_shape_int[i]) * $pow(pulse_shape_int[i], k) / kfactorial;
if(cdf <= thres_cdf) begin</pre>
```





Tph Generator (4)

- 4. Given the SPAD's PDP, a determination is made as to whether each photon's arrival instigates an avalanche
 - If the derived *k* = 2, the comparison between *thres_pdp* and *PDP* is performed twice
 - If the PDP criterion is met for the first time at the *i*-th datum of *pulse_shape_int*,
 Tph = *TOF* + *i* × *Tres* (*Tres*: resolution time of *pulse_shape_int*)

<pre>//For considering PDP of the SPAD thres_pdp = rand_uniform(0,1); if(PDP > thres_pdp) begin signal_sequence = i * Tres; breadure</pre>	<pre>if(signal_sequence != 0) break; end if(signal_sequence != 0) Tph = TOF + signal_sequence; end andmodulo</pre>
break;	endmodule
end	
k = k+1; kfactorial = kfactorial * k;	
end	
else break;	
end	





Dead Time Controller

- Compares *noise_pulse* and *ph_pulse*
- Outputs the final SPAD_pulse







SPAD-Based Sensor Modeling

• The overall block diagram of a SPAD-based sensor configured as a proximity sensor



- TDC_IN toggles whenever 64 SPADs react
- TDC digitizes the timing of TDC_IN toggles using PLL_CLK
- Using ripple counter method, up to 4095 measurements can be made
- Controller adjusts the overall system operation timing

[T. Al Abbas, et al., 2018]





Testbench for a SPAD-Based Sensor Simulation



- PLL_CLK frequency: 600MHz
 - TDC time resolution: 208 ps
 - RMS jitter was set to 6 ps
- Timing Aligner
 - rearranges the histogram outputs (*Count_clk0~7*) according to their actual timing
 - saves the outputs in histogram_output





Timing Diagram of the SPAD-Based Sensor Modeling

- Light pulse cycle was set to 15 ns, including a reset timing of 1.66 ns
 - The sensor can measure up to a distance of about 153 cm
 - A total convergence time of 65 us is required to measure TOF 4095 times







- Light pulse with a dispersed shape (7.5 ns width)
 - Common inputs: TOF = 1.5 ns, PDP = 0.1, DCR = 0.01 counts/ns, Tdead = 10 ns







- Light pulse with a dispersed shape (7.5 ns width)
 - Common inputs: INT = 10 photons/pulse, PDP = 0.1, DCR = 0.01 counts/ns, Tdead = 10 ns







- Light pulse with relatively sharp shape (3.6 ns width)
 - Common inputs: INT = 1 photon/pulse, TOF = 1.5 ns, DCR = 0.01 counts/ns, Tdead = 5 ns







- Light pulse with relatively sharp shape (3.6 ns width)
 - Common inputs: INT = 1 photon/pulse, TOF = 1.5 ns, PDP = 0.1, Tdead = 5 ns







Summary

- This work demonstrated the feasibility of system-level simulation of SPADbased sensors in SystemVerilog using XMODEL primitives
- By utilizing the proposed statistical behavioral model of the SPAD, the entire sensor system can be verified
- A 1.5-meter range proximity sensor completes its simulation in just 4.6 minutes, yielding 4095 histogram data points





Questions

• Thank you



